

Search Notes

Application/Control No.

10/711,916

Examiner

Ryan C. Jager

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	536-7	12/20/2005	RCJ
363	60	12/21/2005	RCJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search	12/28/2005	RCJ
(see search notes)		